PARAMETER MIN TYP MAX UNITS TEST CONDITION						
PARAMETER		IVIIIN	TYP	МАА	UNIIS	TEST CONDITION
Input	Forward Voltage $(V_F)$		1.2	1.4	V	I <sub>F</sub> =20mA
	Reverse Current $(I_R)$		0.05	10	μA	V <sub>R</sub> =6V
Output	Peak Off-state Current ( $I_{DRM}$ ) Peak Blocking Voltage ( $V_{DRM}$ )	600		500	nA V	$V_{DRM} = 600V (note 1)$ $I_{DRM} = 500nA$
	On-state Voltage ( $V_{TM}$ )			3.0	V	$I_{TM} = 100 \text{mA} \text{ (peak)}$
	Critical rate of rise of					
	off-state Voltage ( dv/dt )	600	1500		V/µs	
Coupled	Input Current to Trigger ( $\rm I_{\rm FT}$ )(note 2 )					
	IS620			30	mA	$V_{TM} = 3V (note 2)$
	IS621 IS622			15 10	mA mA	
	IS622 IS623			5	mA	
	Holding Current , either direction ( $I_{\rm H}$ )		400		μΑ	
	Input to Output Isolation Voltage $\tilde{V}_{ISO}$	5300			V <sub>RMS</sub>	See note 3
Zero Crossing Charact- -eristic	Inhibit Voltage (V <sub>IH</sub> )				20 V	V I <sub>F</sub> = Rated I <sub>FT</sub> MT1-MT2 Voltage
	Leakage in Inhibited State ( ${\rm I}_{\rm S}$ )			500	μΑ	above which device will not trigger $I_F = Rated I_{FT}$ $V_{DRM} = 600V \text{ off-state}$

## ELECTRICAL CHARACTERISTICS ( $T_A = 25^{\circ}C$ Unless otherwise noted)

Note 1. Test voltage must be applied within dv/dt rating. Note 2. Guaranteed to trigger at an I<sub>F</sub> value less than or equal to max. I<sub>FT</sub>, recommended I<sub>F</sub> lies between Rated I<sub>FT</sub> and absolute max. I<sub>FT</sub>. Note 3. Measured with input leads shorted together and output leads shorted together.